SN54109, SN54LS109A, SN74109, SN74LS109A

SDLS037 DUAL J-K POSITIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

DECEMBER 1983 - REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

These devices contain two independent $J-\overline{K}$ positive-edge-triggered flip-flops. A low level at the preset or clear inputs sets or resets the outputs regardless of the levels of the other inputs. When preset and clear are inactive (high), data at the J and \overline{K} inputs meeting the setup time requirements are transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold time interval, data at the J and \overline{K} inputs may be changed without affecting the levels at the outputs. These versatile flip-flops can perform as toggle flip-flops by grounding \overline{K} and tying J high. They also can perform as D-type flip-flops if J and \overline{K} are tied together.

The SN54109 and SN54LS109A are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74109 and SN74LS109A are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each flip-flop)

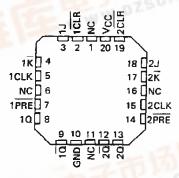
	IN	PUTS			OUT	PUTS
PRE	CLR	CLK	J	K	a	ā
L	Н	х	Х	Х	H	L
Н	L	х	X	X	L .	Н
l L	L	х	X	Х	Нţ	H‡
Н	н	t	L	L	L	Н
н	Н	t	н	L	TOG	SLE
Н	Н	. 1	Ł	н	Q ₀	₫₀
Н	Н	Ť	Н	н	Н	Ł
Н	н	L	Х	Х	20	₫

 $^{^\}dagger$ The output levels in this configuration are not guaranteed to meet the minimum levels for VOH if the lows at preset and clear are near V1L maximum. Furthermore, this configuration is nonstable; that is, it will not persist when preset or clear return to their inactive (high) level.

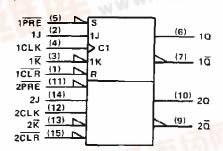
SN54109, SN54LS109A . . . J OR W PACKAGE SN74109 . . . N PACKAGE SN74LS109A . . . D OR N PACKAGE (TOP VIEW)

1CLR	ī	U 16	V _{CC}
1J [2	15	2CLR
1K [3	14	
1CLK []4	13]2K
1PRE	5	12	2 <u>CLK</u>
10[6	11	2PRE
10[7	10]2Q
GND [8	9]2 <u>0</u>

SN54LS109A . . . FK PACKAGE (TOP VIEW)



logic symbol‡

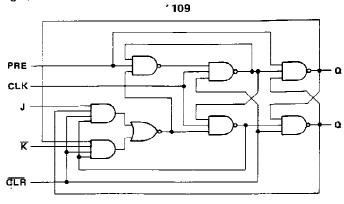


[‡]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

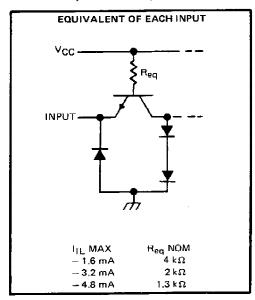
Pin numbers shown are for D, J, N, and W packages.

SN54109, SN74109 DUAL J.K POSITIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

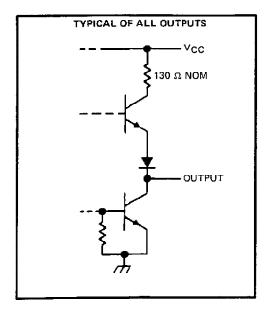
logic diagram (positive logic)

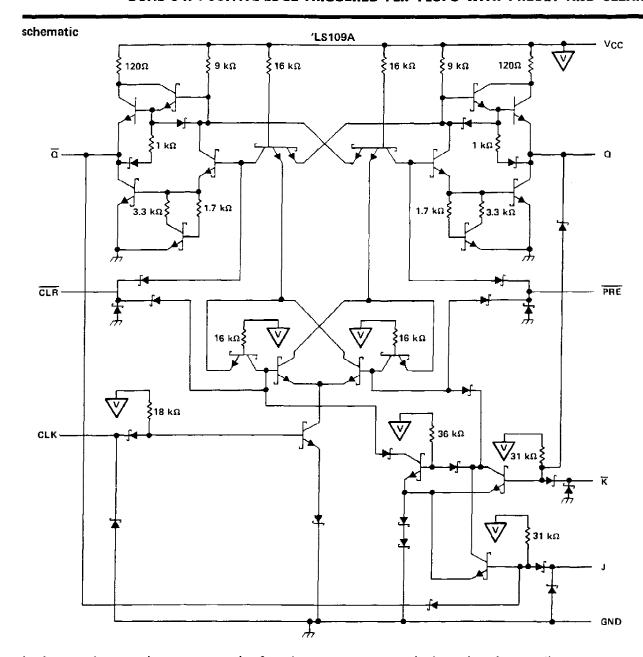


schematics of inputs and outputs









absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)		7 V
Input voltage: '109		5.5 V
'LS109A		7 V
Operating free-air temperature range:	SN54'	- 55°C to 125°C
	SN74'	0°C to 70°C
Storage temperature range		- 65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.



SN54109, SN74109 DUAL J-K POSITIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

recommended operating conditions

				SN54109		SN74109			11807
			MIN	MOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
ViH	High-level input voltage		2	·		2			V
٧١L	Low-level input voltage			.,	8.0			0.8	V
ΙОН	High-level output current				- 0.8			- 0.8	mA
JOL	Low-level output current				16			16	mA
	Pulse duration	CLK high or low	20			20			
t _w	ruise duiation	PRE or CLR law	20			20		T	nş
lsu	Input setup time before CLK 1		10			10			ns
t _{h_}	Input hold time-data after CLK1		6			6			ns
Тд	Operating free-air temperature		55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†			SN5410	9		SN7410	9	LINIT	
					MIN	TYP‡	MAX	MIN	TYP#	MAX	דומט
VIK		V _{CC} = MIN,	= - 12 mA				— 1.5			- 1.5	V
Voн		V _{CC} = MIN, I _{OH} = - 0.8 mA	V _{IH} = 2 V,	V _{IL} = 0.8 V,	2.4	3.4		2.4	3.4		V
Vol		V _{CC} = MIN, I _{OL} = 16 mA	V _{IH} = 2 V,	V _{IL} = 0.8 V,		0.2	0.4		0.2	0.4	v
I _I		V _{CC} = MAX,	V _I = 5.5 V	· · · · · · · · · · · · · · · · · · ·			1			1	mA
	J or K						40			40	
1	CLR	V _{CC} = MAX,	V. ~ 2.4 V				160			160	
Н	PRE or CLK	VCC MAAA	V ₁ = 2.4 V				80			80	μΑ
	J or \overline{K}						- 1.6	-		- 1.6	
1	CLR [¶]	V _{CC} = MAX,	V. = 0.4 V				- 4.8			4.8	mΑ
IIE.	PRE¶	ACC - MAY	V = 0.4 V				- 3.2			- 3.2	1
	CLK						- 3.2			-3.2	
los§		V _{CC} = MAX			- 30		- 85	30		- 85	mA
ICC#		VCC = MAX,	See Note 2	· · · · · · · · · · · · · · · · · · ·		9	15		9	15	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: With all outputs open. ICC is measured with the Q and Q outputs high in turn. At the time of measurement, the clock input is grounded.

switching characteristics, VCC = 5 V, TA = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{max}				25	33		MHz
tpLH	PRE	Q			10	15	nş
^t PHL		ā			23	35	ns
tPLH	CLR	Q	$R_L = 400 \Omega$, $C_L = 15 \rho F$		10	15	ns
t P HL		<u> </u>			17	25	ns
TPLH	CLK	Qora			10	16	ns
^t PHL	- OER	2012			18	28	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



 $^{^{\}ddagger}$ All typical values are at V_{CC} = 5 V, T_A = 25 °C.

[§] Not more than one output should be shorted at a time.

¹ Clear is tested with preset high and preset is tested with clear high.

[#] Average per flip-flop.

SN54LS109A, SN74LS109A DUAL J-K POSITIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

recommended operating conditions

-			SN54LS109A			SN74LS109A			ÚNIT
			MIN	NOM	OM MAX MIN NOM MAX	MAX	וואוטן		
Vcc	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage		2			2			V
VIL	Low-level input voltage		1		0.7			0.8	V
Гон	High-level output current		T		-0.4		•	- 0.4	mA
TOL	Low-level output current				4			8	mA
fclock	Clock frequency		0		25	0		25	MHz
	Pulse duration	CLK high	25			25			
t _w	Pulse duration	PRE or CLR low	25			25			ns
	Courties before CLV 4	High-level data	35			35			
t _{su}	Setup time before CLK 1	Low-level data	25			25			ns
th	Hold time-data after CLK↑		5			5			ns
TA	Operating free-air temperature		- 55		125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DAGAMETER		TEST CONDITIONS†	SI	SN54LS109A		SN	174LS10	9A	
PARAMETER		LEST COMPLLIONS.	MIN TYP‡ MAX MI		MIN	MIN TYP# MAX		דומט	
VIK	V _{CC} = MIN,	I _I = - 18 mA			– 1.5			- 1.5	V
Voн	V _{CC} = MIN, I _{OH} = - 0.4 mA	V _{IH} = 2 V, V _{IL} = M,	AX, 2.5	3.4		2.7	3.4		V
	V _{CC} = MIN, I _{OL} = 4 mA	V _{IL} = MAX, V _{IH} = 2	<i>d</i> ,	0.25	0,4		0.25	0.4	V
VOL	V _{CC} = MIN, f _{OL} = 8 mA	V _{IL} = MAX, V _{IH} = 2	<i>J</i> ,			0,3	0.35	0.5	"
J, K or CLK	Vcc = MAX,	V _I = 7 V			0.1			0.1	
CLR or PRE	VCC - MAX,	· · · · · · · · · · · · · · · · · · ·			0.2	T		0.2	mA
J, R or CLK	V _{CC} = MAX,	V ₁ = 2.7 V			20			20	
IH CLR or PRE	7 400 - 14100	V = 2.7 V			40			40	μА
J, K or CLK	V _{CC} = MAX,	V. = 0.4 V		· -	- 0.4		_	- 0.4	
CLR or PRE	ACC - MAY	V _I = 0.4 V			- 0.8			- 0.8	mA
los §	VCC = MAX,	See Note 4	- 20	_	 100	- 20		- 100	mA
ICC (Total)	V _{CC} = MAX,	See Note 2		4	8		4	8	mA

T For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, VCC = 5 V, TA = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	мах	UNIT
f _{mex}	_			25	33		MHz
^t PLH	CLR, PRE	Q or Q	$R_{\perp} = 2 k\Omega$, $C_{\perp} = 15 pF$		13	25	ns
^t PHL	or CLK	20, 2			25	40	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C. §Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

NOTE 2: With all outputs open, ICC is measured with the Q and Q outputs high in turn. At the time of measurement, the clock input is grounded.

NOTE 4: For certain devices where state commutation can be caused by shorting an output to ground, an equivalent test may be performed with $V_0 = 2.25$ V and 2.125 V for the 54 family and the 74 family, respectively with the minimum and maximum limits reduced to one half of their stated values.

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